

N-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY

V_{DS} (V)	$R_{DS(on)}$ (m Ω)(Typ.)	I_D (A) ^{a, e}	Q_g (Typ.)
40	4.7 at $V_{GS} = 10$ V	70	70 nC
	6 at $V_{GS} = 4.5$ V	65	

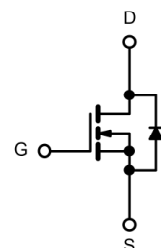
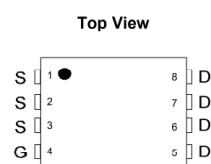
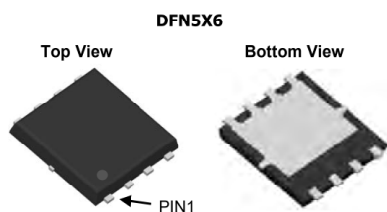
FEATURES

- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested



APPLICATIONS

- Notebook PC Core
- VRM/POL



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	40	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current ($T_J = 175^\circ\text{C}$)	I_D	$T_C = 25^\circ\text{C}$	70 ^{a, e}
		$T_C = 70^\circ\text{C}$	60 ^e
		$T_A = 25^\circ\text{C}$	19 ^{b, c}
		$T_A = 70^\circ\text{C}$	18.6 ^{b, c}
Pulsed Drain Current	I_{DM}	280	
Avalanche Current Pulse	I_{AS}	59	
Single Pulse Avalanche Energy	E_{AS}	210	mJ
Continuous Source-Drain Diode Current	I_S	$T_C = 25^\circ\text{C}$	70 ^{a, e}
		$T_A = 25^\circ\text{C}$	3.5 ^{b, c}
Maximum Power Dissipation	P_D	$T_C = 25^\circ\text{C}$	105 ^a
		$T_C = 70^\circ\text{C}$	55
		$T_A = 25^\circ\text{C}$	6.15 ^{b, c}
		$T_A = 70^\circ\text{C}$	3.05 ^{b, c}
Operating Junction and Storage Temperature Range	T_J, T_{stg}	- 55 to 175	$^\circ\text{C}$

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, d}	R_{thJA}	15	25	$^\circ\text{C/W}$
Maximum Junction-to-Case	R_{thJC}	1.0	1.5	

Notes:

a. Based on $T_C = 25^\circ\text{C}$.

b. Surface mounted on 1" x 1" FR4 board.

c. $t = 10$ s.

d. Maximum under steady state conditions is 90°C/W .

e. Calculated based on maximum junction temperature.

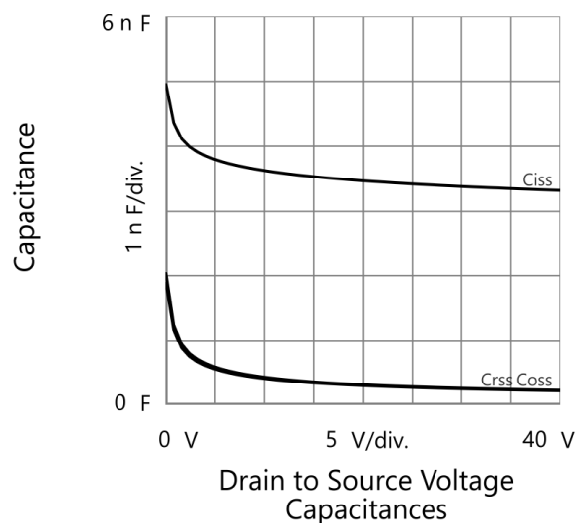
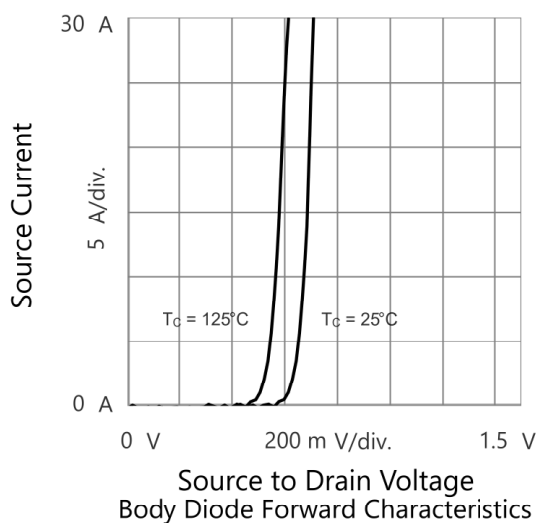
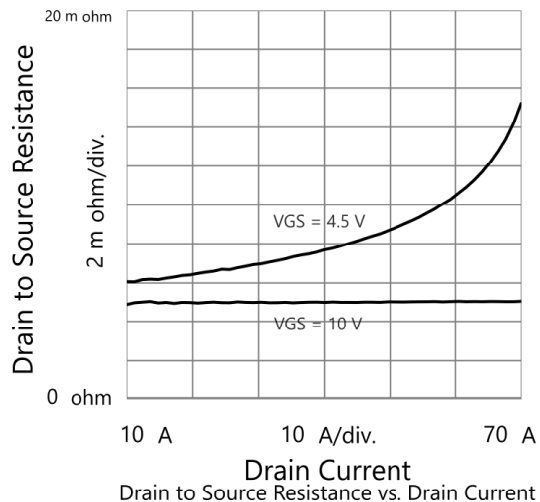
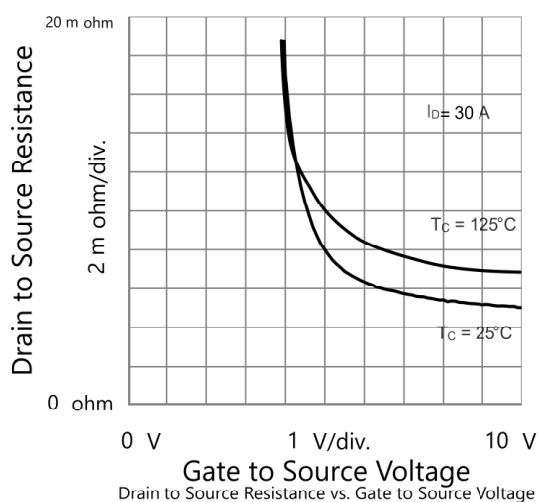
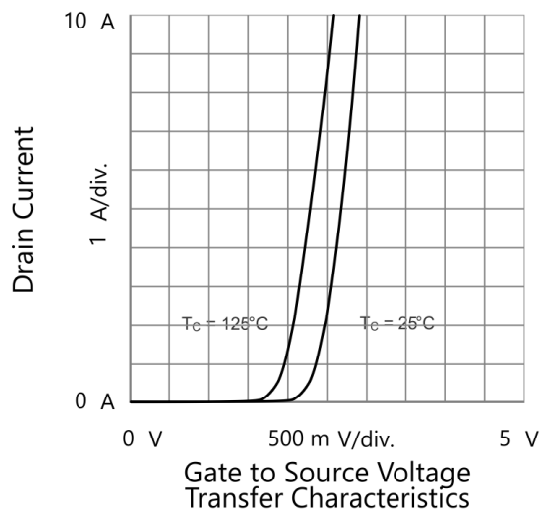
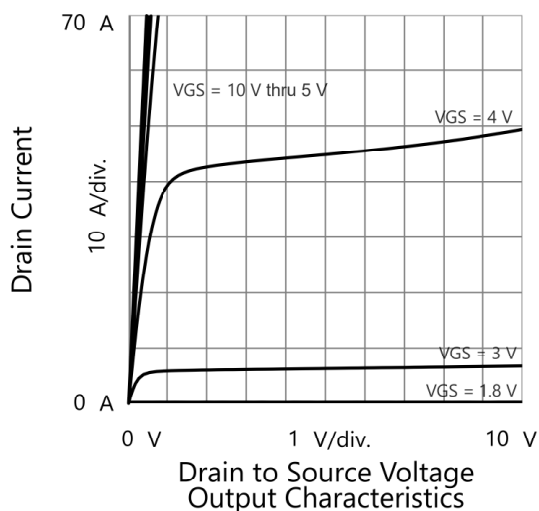
SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)						
Parameter	Symbol	Test Conditions	Min .	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	40			V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = 250 μA		35		mV/°C
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} /T _J			- 5.5		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1.2		2.5	V
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V			1	μA
		V _{DS} = 40 V, V _{GS} = 0 V, T _J = 55 °C			10	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	70			A
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 30 A		4.7	5.2	mΩ
		V _{GS} = 4.5 V, I _D = 20 A		6	7	
Forward Transconductance ^a	g _{fs}	V _{DS} = 15 V, I _D = 30 A		110		S
Dynamic ^b						
Input Capacitance	C _{iss}	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz		3470		pF
Output Capacitance	C _{oss}			315		
Reverse Transfer Capacitance	C _{rss}			300		
Total Gate Charge	Q _g	V _{DS} = 20 V, V _{GS} = 10 V, I _D = 30 A		70		nC
Gate-Source Charge	Q _{gs}			32		
Gate-Drain Charge	Q _{gd}			27		
Gate Resistance	R _g	f = 1 MHz		2.2		Ω
Turn-On Delay Time	t _{d(on)}	V _{DD} = 15 V, R _L = 0.555 Ω I _D ≅ 30 A, V _{GEN} = 10 V, R _g = 1 Ω		18		ns
Rise Time	t _r			11		
Turn-Off Delay Time	t _{d(off)}			70		
Fall Time	t _f			10		
Turn-On Delay Time	t _{d(on)}	V _{DD} = 15 V, R _L = 0.625 Ω I _D ≅ 20 A, V _{GEN} = 4.5 V, R _g = 1 Ω		55		
Rise Time	t _r			180		
Turn-Off Delay Time	t _{d(off)}			55		
Fall Time	t _f			12		
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			70	A
Pulse Diode Forward Current ^a	I _{SM}				280	
Body Diode Voltage	V _{SD}	I _S = 1 A		0.6	1	V
Body Diode Reverse Recovery Time	t _{rr}	I _F = 30 A, di/dt = 100 A/μs, T _J = 25 °C		52	78	ns
Body Diode Reverse Recovery Charge	Q _{rr}			70.2	105	nC
Reverse Recovery Fall Time	t _a			27		ns
Reverse Recovery Rise Time	t _b			25		

Notes:

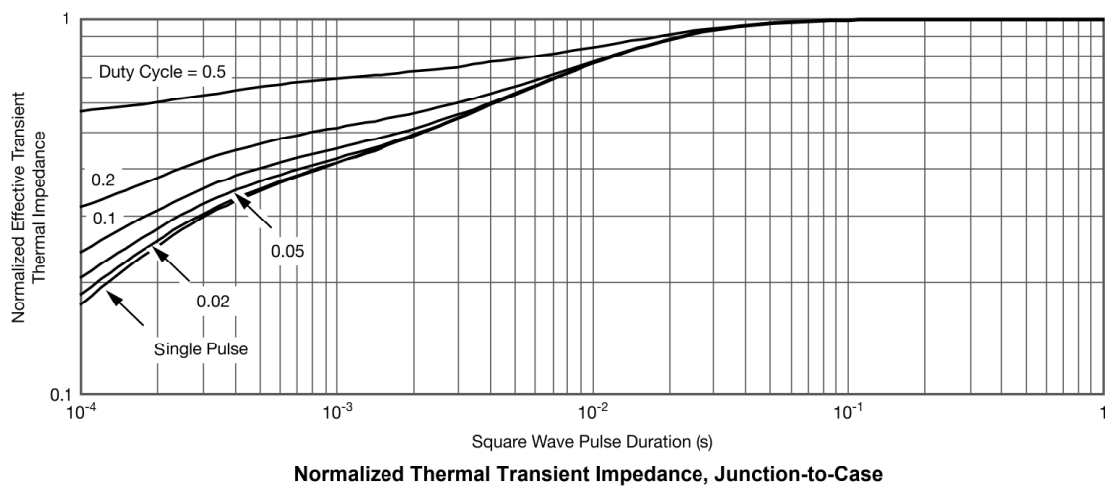
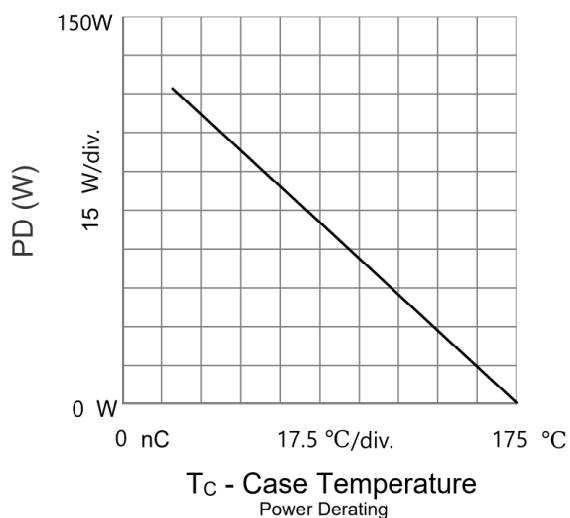
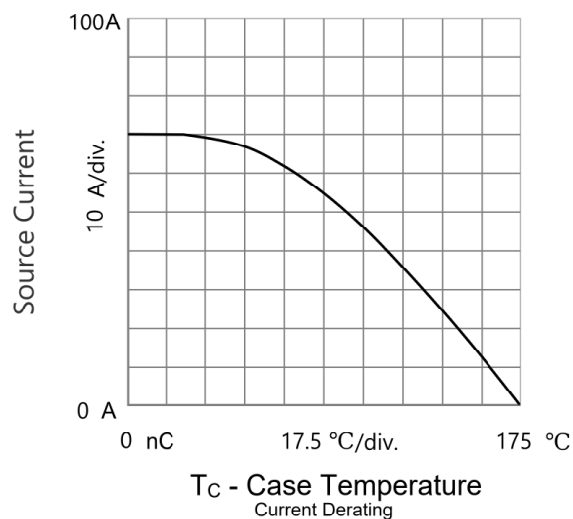
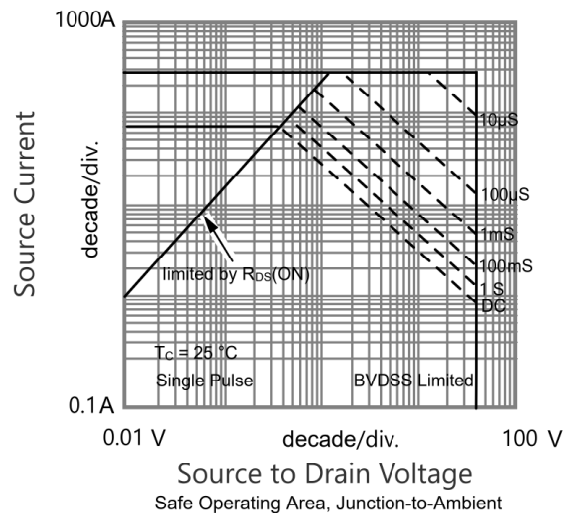
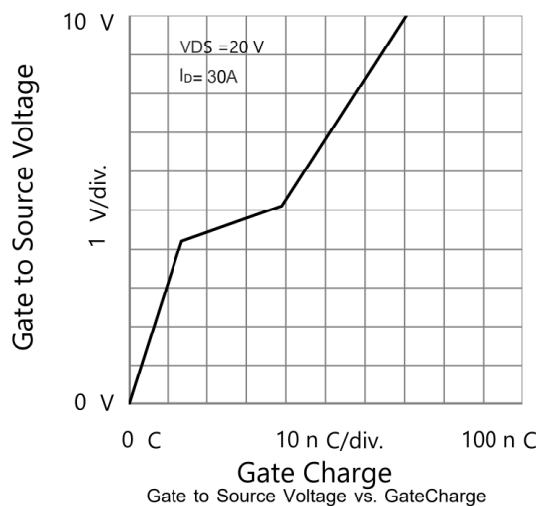
- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.
 b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



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